

Li+ Charger Protection IC with Integrated P-MOSFET

Features

- Input Over-Voltage Protection
- Input Over-Current Protection
- Battery Over-Voltage Protection
- High Immunity of False Triggering
- High Accuracy Protection Threshold
- A Built-In P-MOSFET
- Thermal Shutdown Protection
- Compliance to IEC61000-4-2 (Level 4)
 - ± 8kV (Contact Discharge)
 - ± 15kV (Air Discharge)
- Available in a TDFN2x2-8 and TSOT-23-6A Packages
- Lead Free and Green Devices Available (RoHS Compliant)

General Description

The APL3206/A/B provides complete Li+ charger protection against input over-voltage, input over-current, and battery over-voltage. When any of the monitored parameters are over the threshold, the IC removes the power from the charging system by turning off an internal switch. All protections also have deglitch time against false triggering due to voltage spikes or current transients.

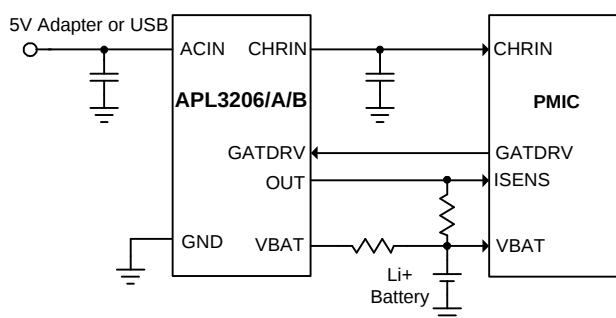
The APL3206/A/B integrates a P-MOSFET with the body diode reverse protection to replace the external P-MOSFET and Schottky diode for charger function of cell phone's PMIC. When the CHRIN voltage drops below $V_{BAT} + 20mV$, the internal power select circuit will reverse the body diode's terminal to prevent a reverse current flowing from the battery back to CHRIN pin.

The APL3206/A/B provides complete Li+ charger protections and saves the external MOSFET and Schottky diode for the charger of cell phone's PMIC. The above features and small package make the APL3206/A/B an ideal part for cell phones applications.

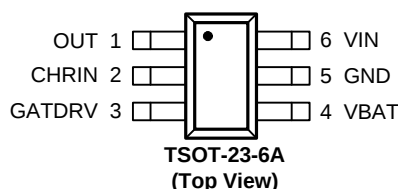
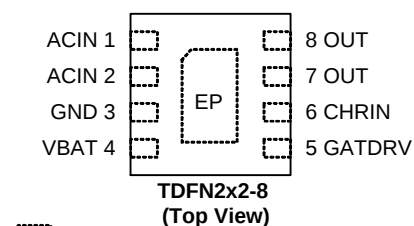
Applications

- Cell Phones

Simplified Application Circuit

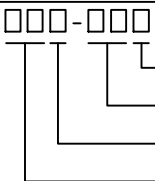


Pin Configuration



ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Ordering and Marking Information

APL3206 APL3206A APL3206B		Package Code QB : TDFN2x2-8 CT : TSOT-23-6A Operating Ambient Temperature Range I : -40 to 85 °C Handling Code TR : Tape & Reel Assembly Material G : Halogen and Lead Free Device
APL3206 QB:	L06 X	X - Date Code
APL3206A QB:	L6A X	X - Date Code
APL3206B QB:	L6B X	X - Date Code
APL3206 CT:	L06X	X - Date Code
APL3206A CT:	L6AX	X - Date Code
APL3206B CT:	L6BX	X - Date Code

Note: ANPEC lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. ANPEC defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Rating	Unit
V_{ACIN}	ACIN Input Voltage (ACIN to GND)	-0.3 ~ 30	V
V_{CHRIIN}	CHRIIN to GND Voltage	-0.3 ~ 7	V
V_{GATDRV}	GATDRV to GND Voltage	-0.3 ~ V_{CHRIIN}	V
V_{BAT}	VBAT to GND Voltage	-0.3 ~ 7	V
V_{OUT}	OUT to GND Voltage	-0.3 ~ 7	V
I_{OUT}	OUT Output Current	1.5	A
T_J	Maximum Junction Temperature	150	°C
T_{STG}	Storage Temperature	-65 ~ 150	°C
T_{SDR}	Maximum Lead Soldering Temperature, 10 Seconds	260	°C

Note 1: Absolute Maximum Ratings are those values beyond which the life of a device may be impaired. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Thermal Characteristic

Symbol	Parameter	Typical Value	Unit
θ_{JA}	Junction-to-Ambient Resistance in Free Air ^(Note 2)		
	TDFN2x2-8	80	°C/W
	TSOT-23-6A	235	

Note 2: θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. The exposed pad of TDFN2x2-8 is soldered directly on the PCB.

Recommended Operating Conditions (Note 3)

Symbol	Parameter	Range	Unit
V_{ACIN}	ACIN Input Voltage	4.5 ~ 5.5	V
I_{OUT}	Output Current	0 ~ 700	mA
T_A	Ambient Temperature	-40 ~ 85	°C
T_J	Junction Temperature	-40 ~ 125	°C

Note 3: Refer to the typical application circuit

Electrical Characteristics

Unless otherwise specified, these specifications apply over $V_{ACIN}=5V$, $V_{BAT}=3.8V$ and $T_A = -40 \sim 85$ °C. Typical values are at $T_A=25$ °C.

Symbol	Parameter	Test Conditions	APL3206/A/B			Unit	
			Min.	Typ.	Max.		
ACIN INPUT CURRENT AND POWER-ON-RESET (POR)							
I _{ACIN}	ACIN Supply Current	I _{OUT} =0A, I _{CH_{RIN}} =0A	-	250	350	μA	
V _{ACIN}	ACIN POR Threshold	V _{ACIN} rising	2.4	-	2.8	V	
	ACIN POR Hysteresis		200	250	300	mV	
T _{B(ACIN)}	ACIN Power-On Blanking Time		-	8	-	ms	
INTERNAL SWITCH ON RESISTANCE							
	ACIN to OUT On Resistance	I _{OUT} =0.7A	-	0.5	-	Ω	
	CH _{RIN} Discharge On Resistance		-	500	-	Ω	
INPUT OVER-VOLTAGE PROTECTION (OVP)							
V _{OVP}	Input OVP Threshold	V _{ACIN} rising	APL3206	6	6.17	6.35	V
			APL3206A	6.6	6.8	7	
			APL3206B	7.5	7.65	7.8	
	Input OVP Hysteresis		200	300	400	mV	
	Input OVP Propagation Delay		-	-	1	μs	
T _{ON(OVP)}	Input OVP Recovery Time		-	8	-	ms	
OVER-CURRENT PROTECTION (OCP)							
I _{OCP}	OCP Threshold		1	-	1.55	A	
T _{B(OCP)}	OCP Blanking Time		-	176	-	μs	
T _{ON(OCP)}	OCP Recovery Time		-	64	-	ms	
BATTERY OVER-VOLTAGE PROTECTION							
V _{BOVP}	Battery OVP Threshold	V _{BAT} rising	4.32	4.35	4.38	V	
	Battery OVP Hysteresis		220	270	320	mV	
I _{VBAT}	VBAT Pin Leakage Current	V _{BAT} = 4.4V	-	-	20	nA	
T _{B(BOVP)}	Battery OVP Blanking Time		-	176	-	μs	
INTERNAL P-MOSFET (CH _{RIN} , OUT, AND GATDRV PINS)							
	V _{CH_{RIN}} -V _{BAT} Lockout Threshold	V _{CH_{RIN}} from low to high, P-MOSFET is controlled by GATDRV	-	150	-	mV	
		V _{CH_{RIN}} from high to low, P-MOSFET is off	-	20	-		
	OUT Input Current	V _{CH_{RIN}} =0V, V _{OUT} =4.2V, GATDRV=GND	-	-	1	μA	
	GATDRV Leakage Current	V _{ACIN} =V _{CH_{RIN}} = V _{OUT} =5V, V _{GATDRV} =0V	-	-	1	μA	
	OUT Leakage Current	V _{ACIN} =V _{CH_{RIN}} = V _{GATDRV} =5V, V _{OUT} =0V	-	-	1	μA	

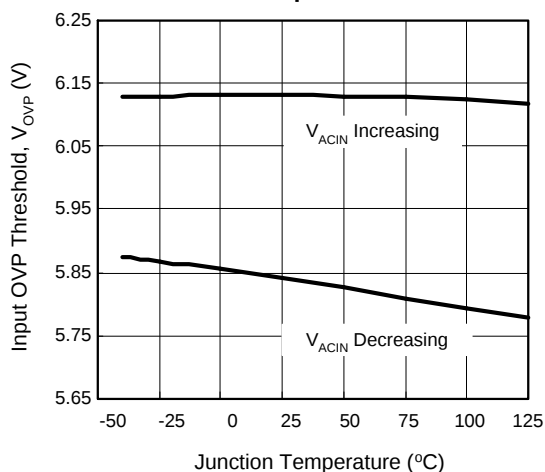
Electrical Characteristics (Cont.)

Unless otherwise specified, these specifications apply over $V_{ACIN}=5V$, $V_{BAT}=3.8V$ and $T_A=-40 \sim 85 \text{ }^{\circ}C$. Typical values are at $T_A=25^{\circ}C$.

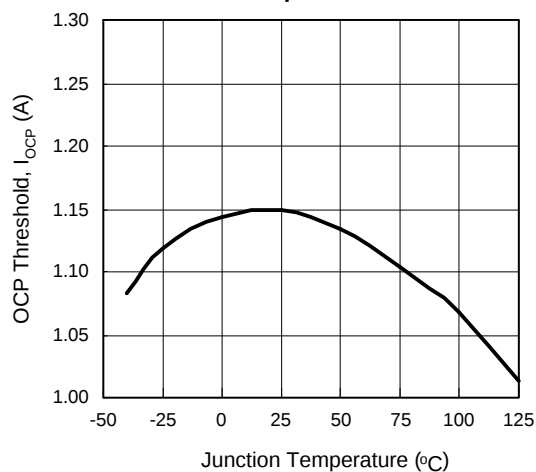
Symbol	Parameter	Test Conditions	APL3206/A/B			Unit
			Min.	Typ.	Max.	
INTERNAL P-MOSFET (CH _{RIN} , OUT, AND GATDRV PINS) (CONT.)						
	P-MOSFET Input Capacitance		-	200	-	pF
	GATDRV Input Resistance		-	15	-	Ω
OVER-TEMPERATURE PROTECTION (OTP)						
T _{OTP}	Over-Temperature Threshold	T _J rising	-	160	-	°C
	Over-Temperature Hysteresis		-	40	-	°C

Typical Operating Characteristics

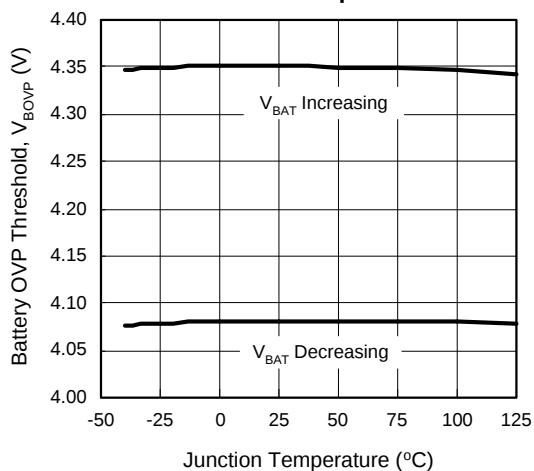
Input OVP Threshold vs. Junction Temperature



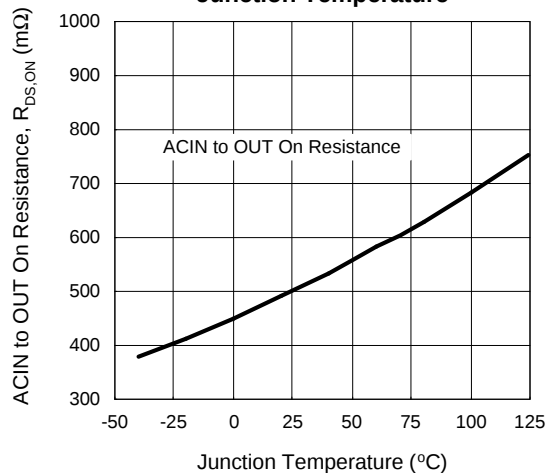
OCP Threshold vs. Junction Temperature



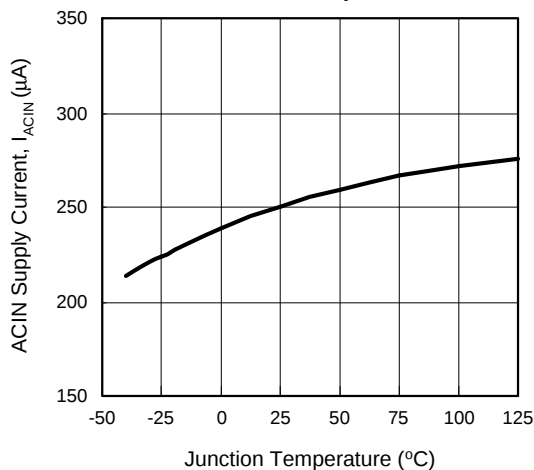
Battery OVP Threshold vs. Junction Temperature



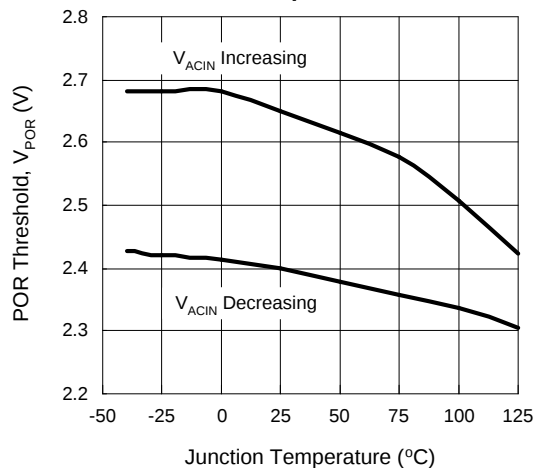
ACIN to OUT On Resistance vs. Junction Temperature



ACIN Supply Current vs. Junction Temperature



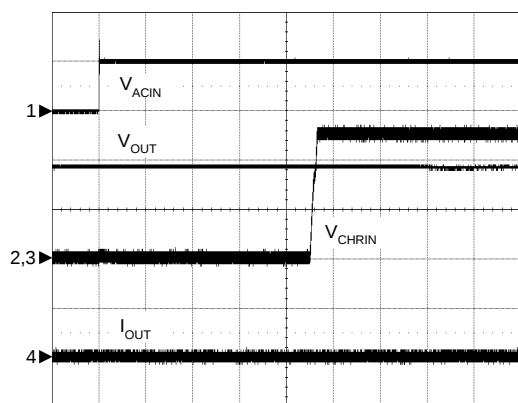
POR Threshold vs. Junction Temperature



Operating Waveforms

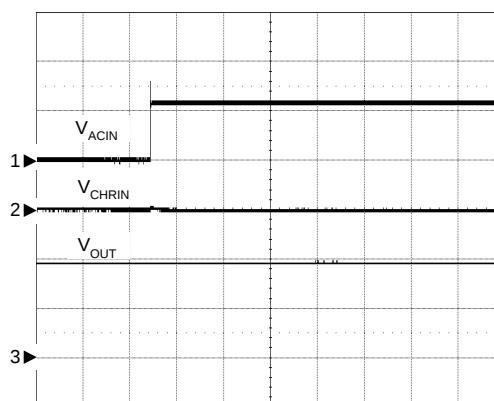
The test condition is $V_{ACIN}=5V$, $V_{BAT}=3.8V$, $C_{ACIN}=1\mu F$, $C_{CHIN}=1\mu F$, $T_A=25^\circ C$ unless otherwise specified.

Normal Power On



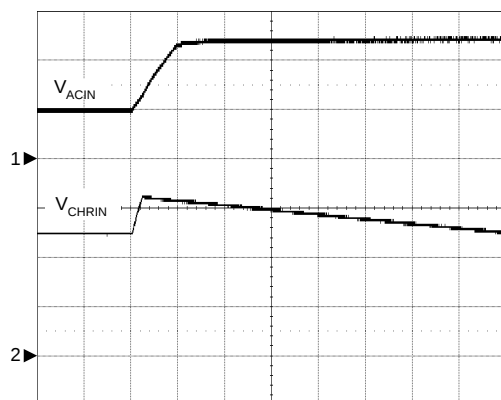
$V_{GATDRV} = V_{CHIN}$
 CH1: V_{ACIN} , 5V/Div, DC
 CH2: V_{OUT} , 2V/Div, DC
 CH3: V_{CHIN} , 2V/Div, DC
 CH4: I_{OUT} , 0.2A/Div, DC
 TIME: 2ms/Div

OVP at Power On



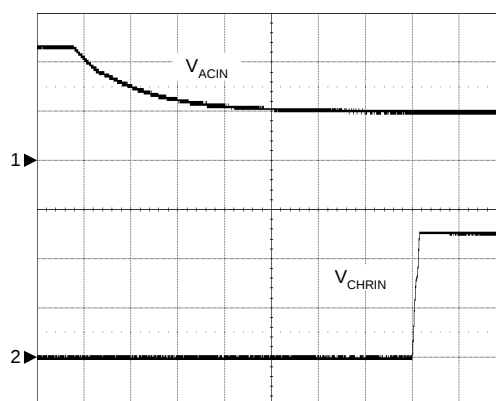
$V_{ACIN} = 0$ to 12V, $V_{GATDRV} = V_{CHIN}$
 CH1: V_{ACIN} , 10V/Div, DC
 CH2: V_{CHIN} , 2V/Div, DC
 CH3: V_{OUT} , 2V/Div, DC
 TIME: 2ms/Div

Input Over-Voltage Protection



$V_{ACIN} = 5V$ to 12V
 CH1: V_{ACIN} , 5V/Div, AC
 CH2: V_{CHIN} , 2V/Div, DC
 TIME: 20μs/Div

Recovery from Input OVP

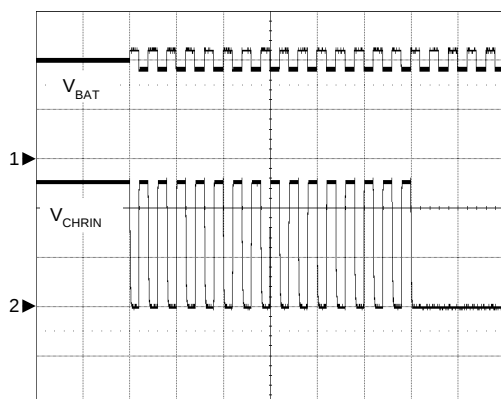


$V_{ACIN} = 12V$ to 5V
 CH1: V_{ACIN} , 5V/Div, AC
 CH2: V_{CHIN} , 2V/Div, DC
 TIME: 2ms/Div

Operating Waveforms (Cont.)

The test condition is $V_{ACIN}=5V$, $V_{BAT}=3.8V$, $C_{ACIN}=1\mu F$, $C_{CHIRN}=1\mu F$, $T_A=25^\circ C$ unless otherwise specified.

Battery Over-Voltage Protection



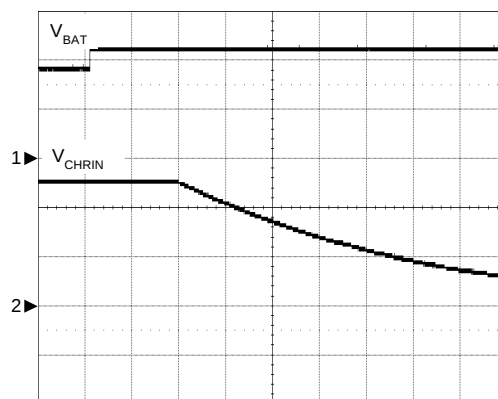
$V_{BAT} = 3.6V$ to $4.4V$ to $3.6V$

CH1: V_{BAT} , 2V/Div, AC

CH2: V_{CHIRN} , 2V/Div, DC

TIME: 50ms/Div

Battery Over-Voltage Protection



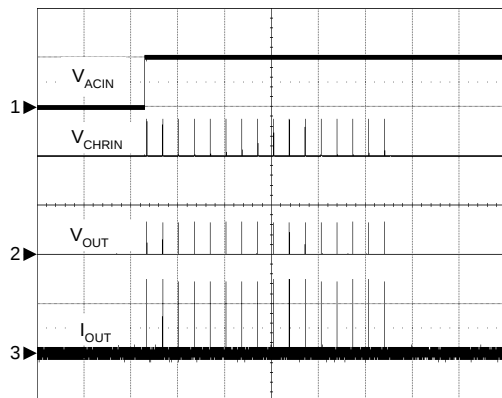
$V_{BAT} = 3.6V$ to $4.4V$

CH1: V_{BAT} , 2V/Div, DC

CH2: V_{CHIRN} , 2V/Div, DC

TIME: 200 μ s/Div

Over-Current Protection



$R_{OUT}=2.5\Omega$, $V_{BAT}=0V$, $V_{GATDRV}=0V$

CH1: V_{ACIN} , 5V/Div, DC

CH2: V_{CHIRN} , 5V/Div, DC

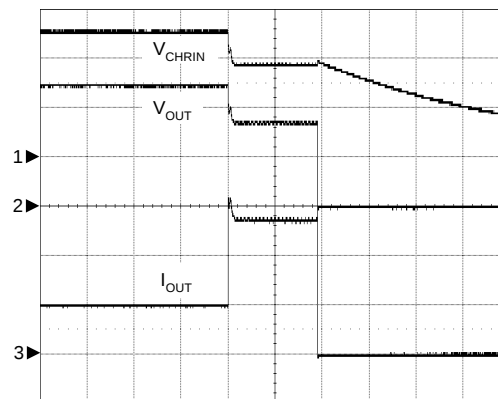
CH3: V_{OUT} , 5V/Div, DC

CH4: I_{OUT} , 1A/Div, DC

TIME: 200ms/Div

Note: OUT pin connected with a resistor to ground.

Over-Current Protection



$R_{OUT}=10\Omega$ to 2.4Ω , $V_{BAT}=0V$, $V_{GATDRV}=0V$

CH1: V_{CHIRN} , 2V/Div, DC

CH2: V_{OUT} , 2V/Div, DC

CH3: I_{OUT} , 0.5A/Div, DC

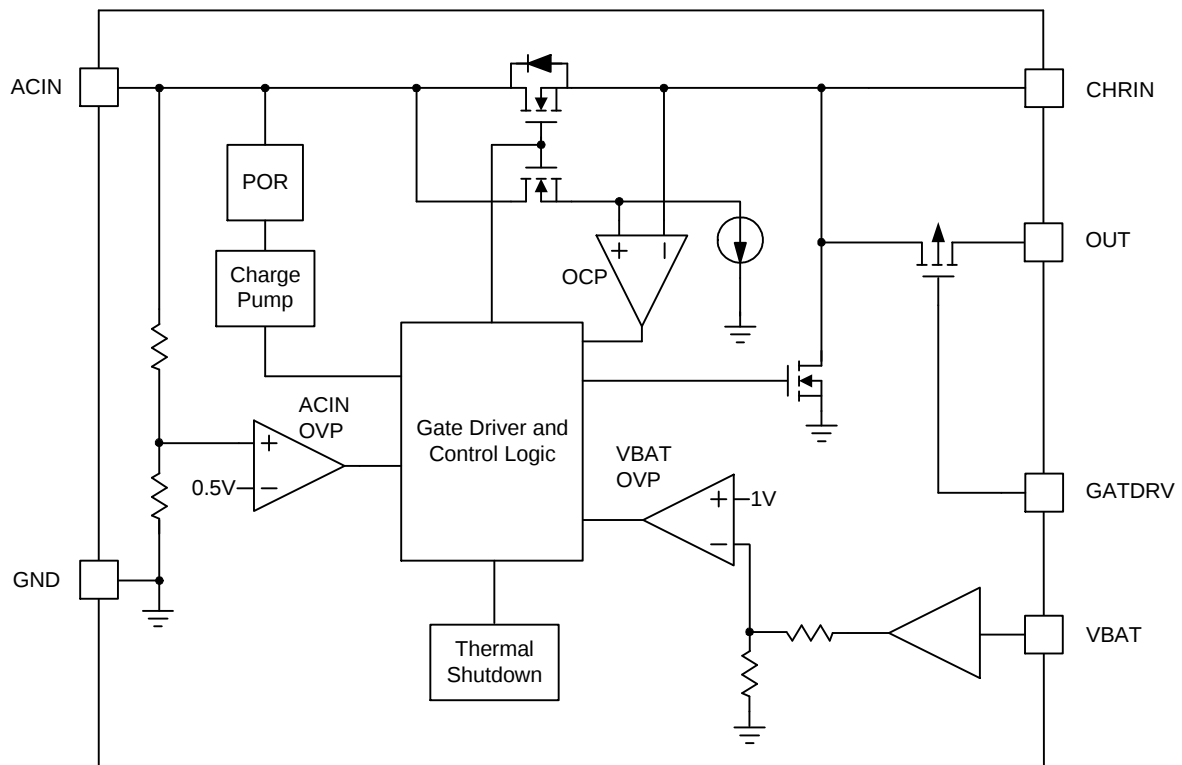
TIME: 100 μ s/Div

Note: OUT pin connected with a resistor to ground.

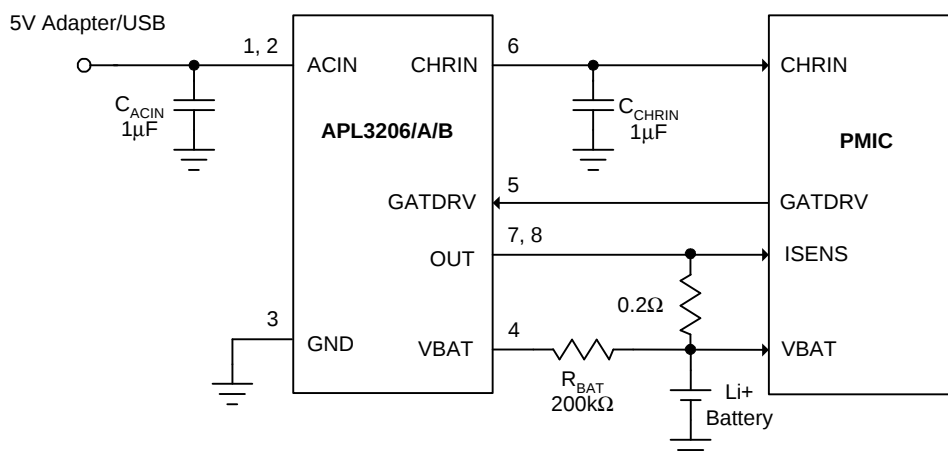
Pin Description

PIN		FUNCTION
NO.	NAME	
1,2	ACIN	Power Supply Input. Connect this pin to external DC supply. Bypass to GND with a 1 μ F (minimum) ceramic capacitor.
3	GND	Ground Terminal.
4	VBAT	Battery Voltage Sense Input. Connect this pin to pack positive terminal through a resistor.
5	GATDRV	Internal P-MOSFET Gate Input.
6	CHRIN	Output Pin. This pin provides supply voltage to the PMIC input. Bypass to GND with a 1 μ F (minimum) ceramic capacitor.
7,8	OUT	Output Pins. These pins provide supply source current in series with a resistor to battery.
-	EP	Exposed Thermal Pad. Must be electrically connected to the GND pin.

Block Diagram



Typical Application Circuit



Designation	Description
C_{ACIN}	1µF, 25V, X5R, 0603 Murata GRM188R61E105K
C_{CHRIN}	1µF, 10V, X5R, 0603 Murata GRM188R61A105K

Murata website: www.murata.com

Function Description

ACIN Power-On-Reset (POR)

The APL3206/A/B has a built-in power-on-reset circuit to keep the output shutting off until internal circuitry is operating properly. The POR circuit has hysteresis and a de-glitch feature so that it will typically ignore undershoot transients on the input. When the input voltage exceeds the POR threshold and after 8ms blanking time, the output voltage starts a soft-start to reduce the inrush current.

ACIN Over-Voltage Protection (OVP)

The input voltage is monitored by the internal OVP circuit. When the input voltage rises above the input OVP threshold, the internal FET will be turned off within 1ms to protect connected system on OUT pin. When the input voltage returns below the input OVP threshold minus the hysteresis, the FET is turned on again after 8ms recovery time. The input OVP circuit has a 300mV hysteresis and a recovery time of $T_{ON(OVP)}$ to provide noise immunity against transient conditions.

Over-Current Protection (OCP)

The output current is monitored by the internal OCP circuit. When the output current reaches the OCP threshold, the device limits the output current at OCP threshold level. If the OCP condition continues for a blanking time of $T_{B(OCP)}$, the internal power FET is turned off. After the recovery time of $T_{ON(OCP)}$, the FET will be turned on again. The APL3206/A/B has a built-in counter. When the total count of OCP fault reaches 16, the FET is turned off permanently, requiring a V_{ACIN} POR again to restart.

Battery Over-Voltage Protection

The APL3206/A/B monitors the VBAT pin voltage for battery over-voltage protection. The battery OVP threshold is internally set to 4.35V. When the VBAT pin voltage exceeds the battery OVP threshold for a blanking time of $T_{B(BOVP)}$, the internal power FET is turned off. When the VBAT voltage returns below the battery OVP threshold minus the hysteresis, the FET is turned on again. The APL3206/A/B has a built-in counter. When the total count of battery OVP fault reaches 16, the FET is turned off permanently, requiring a V_{ACIN} POR again to restart.

Over-Temperature Protection

When the junction temperature exceeds 160°C, the internal thermal sense circuit turns off the power FET and allows the device to cool down. When the device's junction temperature cools by 40°C, the internal thermal sense circuit will enable the device, resulting in a pulsed output during continuous thermal protection. Thermal protection is designed to protect the IC in the event of over temperature conditions. For normal operation, the junction temperature cannot exceed $T_J=+125^{\circ}\text{C}$.

Internal P-MOSFET

The APL3206/A/B integrates a P-channel MOSFET with the body diode reverse protection to replace the external P-MOSFET and Schottky diode for cell phone's PMIC. The body diode reverse protection prevents a reverse current flowing from the battery back to CHRIN pin. During power-on, when CHRIN voltage rises above the VBAT voltage by more than 150mV, the body diode of the P-channel MOSFET is forward biased from OUT to CHRIN, and P-MOSFET is controlled by the external GATDRV voltage. When the CHRIN voltage drops below $V_{BAT}+20\text{mV}$, the body diode of the P-channel MOSFET is forward biased from CHRIN to OUT and P-channel MOSFET is turned off. When any of input OVP, OCP, battery OVP, is detected, the internal P-channel MOSFET is also turned off.

ESD Tests

The APL3206/A/B VIN input pin fully supports the IEC61000-4-2. That means the VIN pin has immunity of $\pm 15\text{kV}$ ESD discharge in Air condition, and immunity of $\pm 8\text{kV}$ ESD discharge in Contact condition.

Function Description (Cont.)

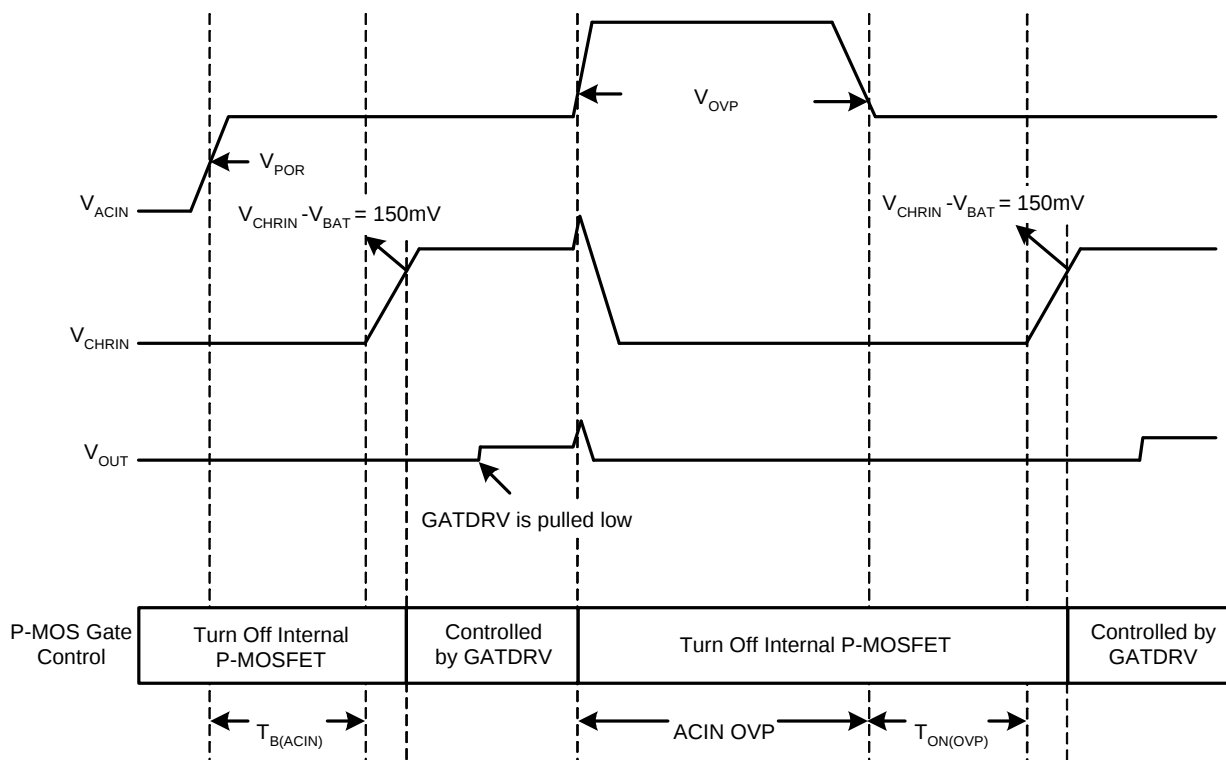


Figure 1. OVP Timing Diagram

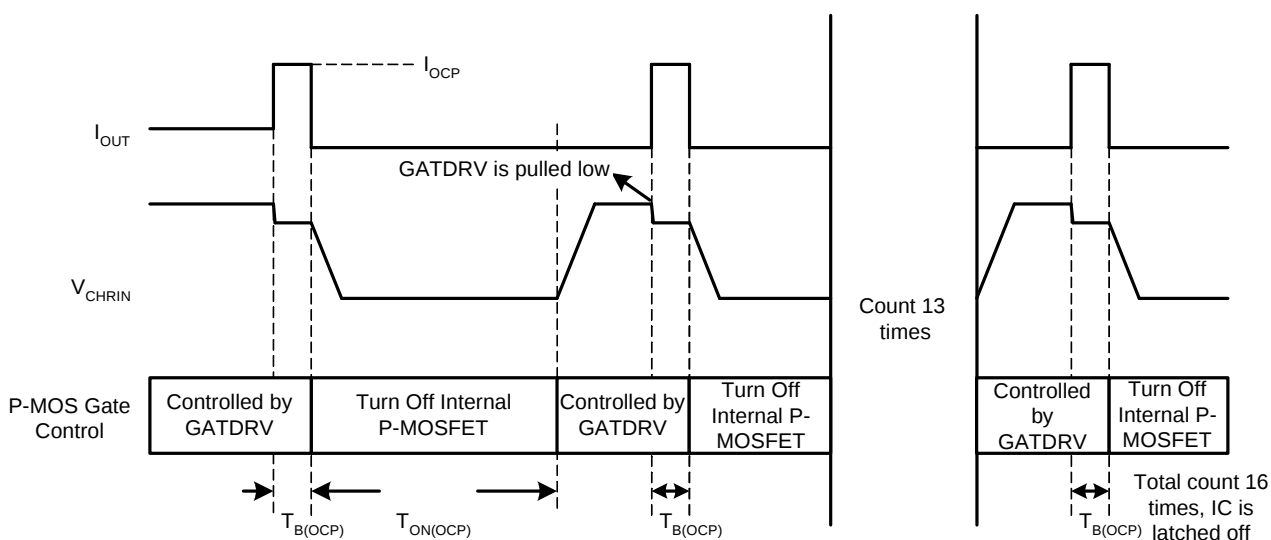


Figure 2. OCP Timing Diagram

Function Description (Cont.)

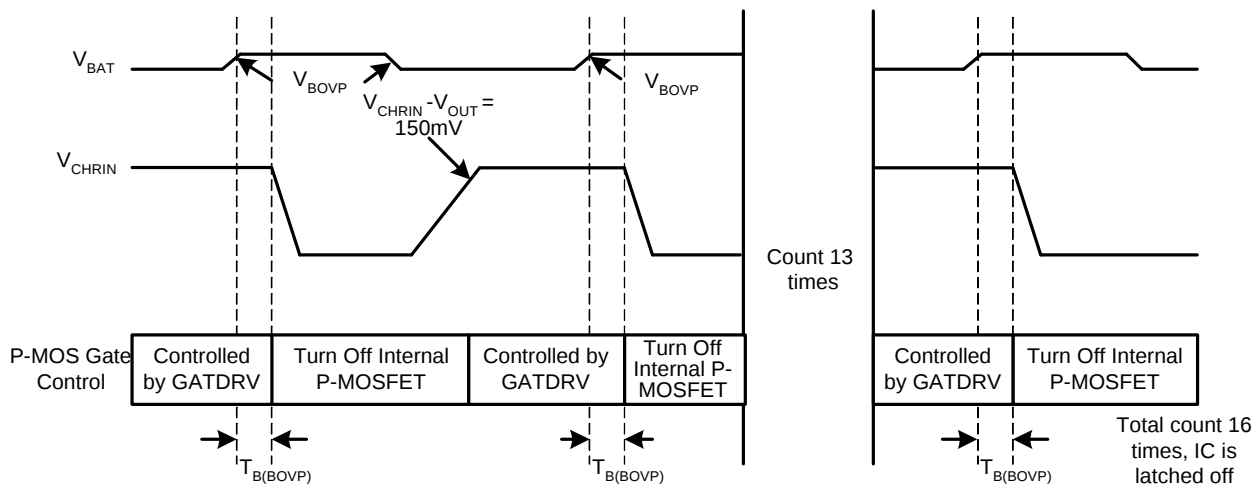


Figure 3. Battery OVP Timing Diagram

Application Information

R_{BAT} Selection

Connect the VBAT pin to the positive terminal of battery through a resistor R_{BAT} for battery OVP function. The R_{BAT} limits the current flowing from VBAT to battery in case of VBAT pin is shortened to ACIN pin under a failure mode. The recommended value of R_{BAT} is 200kΩ. In the worse case of an IC failure, the current flowing from the VBAT pin to the battery is:

$$(30V-3V) / 200k\Omega = 135\mu A$$

where the 30V is the maximum ACIN voltage and the 3V is the minimum battery voltage. The current is so small and can be absorbed by the charger system.

Capacitor Selection

The input capacitor is for decoupling and prevents the input voltage from overshooting to dangerous levels. In the AC adapter hot plug-in applications or load current step-down transient, the input voltage has a transient spike due to the parasitic inductance of the input cable. A 25V, X5R, dielectric ceramic capacitor with a value between 1μF and 4.7μF placed close to the ACIN pin is recommended.

The output capacitor of CHRIN is for CHRIN voltage decoupling. And also can be as the input capacitor of the charging circuit. At least, a 1μF, 10V, X5R capacitor is recommended.

Thermal Considerations

The maximum power dissipation depends on the thermal resistance of IC package, PCB layout, the rate of surroundings airflow and temperature difference between junction to ambient. The maximum power dissipation can be calculated by the following formula:

$$P_{D(MAX)} = (T_{J(MAX)} - T_A) / \theta_{JA}$$

Where T_{J(MAX)} is the maximum operation junction temperature, T_A is the ambient temperature and the θ_{JA} is the junction to ambient thermal resistance. For recommended operating conditions specification of APL3206/A, where T_{J(MAX)} is 125°C and T_A is the operated ambient temperature. The junction to ambient thermal resistance θ_{JA} for TDFN2x2-8 package is 165°C/W and TSOT-23-6A package is 220°C/W on the standard JEDEC 51-3 single-layer thermal test board. The maximum power dissipa-

tion at T_A = 25°C can be calculated by following formula :

$$P_{D(MAX)} = (125^\circ C - 25^\circ C) / (165^\circ C/W) = 0.606W$$

for TDFN2x2-8 packages

$$P_{D(MAX)} = (125^\circ C - 25^\circ C) / (220^\circ C/W) = 0.455W$$

for TSOT-23-6A packages

The maximum power dissipation depends on operating ambient temperature for fixed T_{J(MAX)} and thermal resistance θ_{JA}. For APL3206/A packages, the Figure 4 of derating curves allows the designer to see the effect of rising ambient temperature on the maximum power allowed.

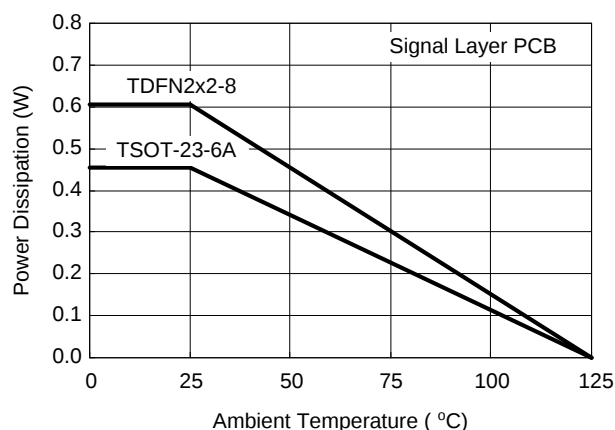


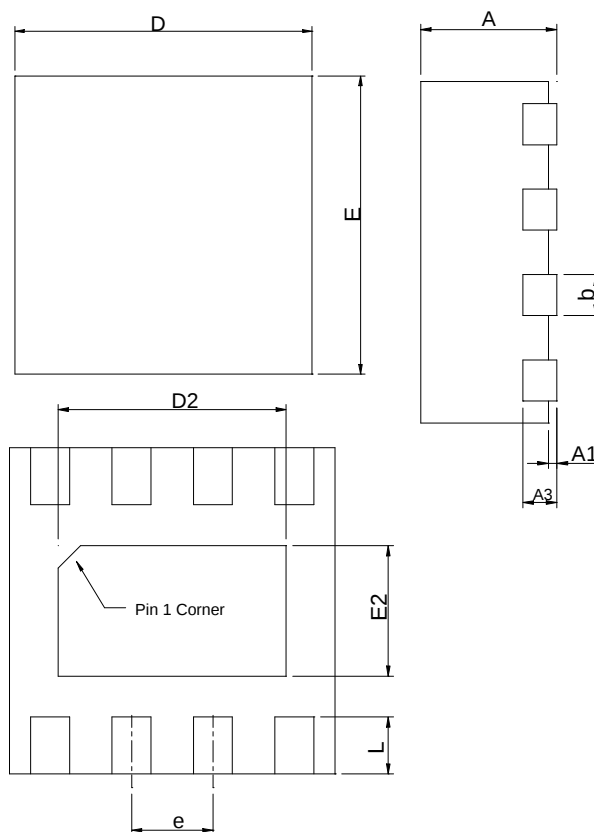
Figure 4. Derating Curves for APL3206/A Packages

Layout Consideration

In some failure modes, a high voltage may be applied to the device. Make sure the clearance constraint of the PCB layout must satisfy the design rule for high voltage. The exposed pad of the TDFN2x2-8 performs the function of channeling heat away. It is recommended that connect the exposed pad to a large copper ground plane on the backside of the circuit board through several thermal vias to improve heat dissipation. The input and output capacitors should be placed close to the IC. The high current traces like input trace and output trace must be wide and short.

Package Information

TDFN2x2-8

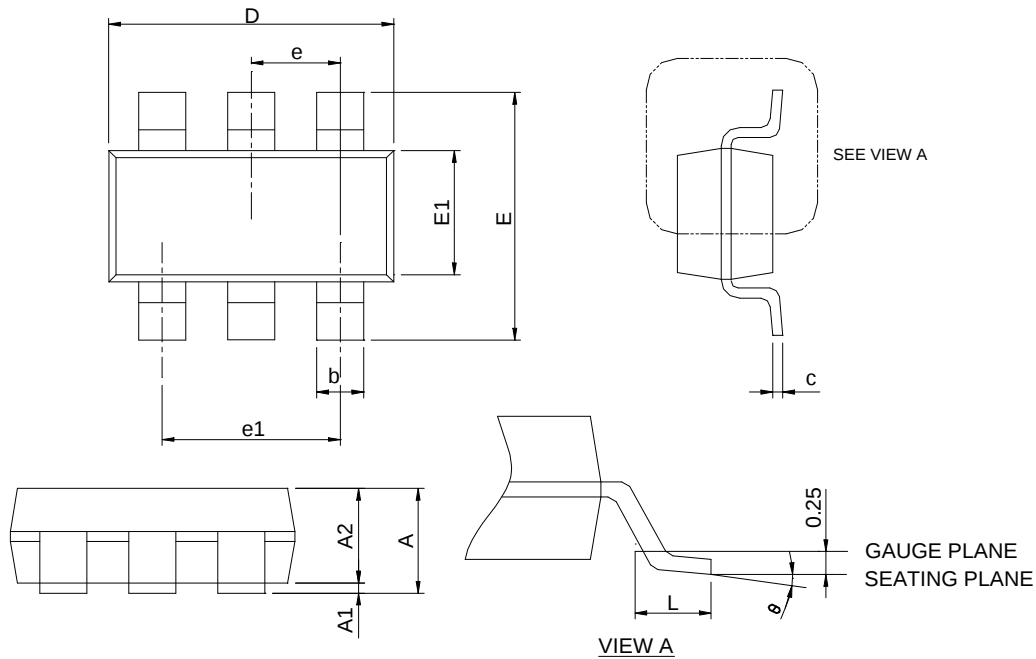


SYMBOL	TDFN2x2-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	0.80	0.028	0.031
A1	0.00	0.05	0.000	0.002
A3	0.20 REF		0.008 REF	
b	0.18	0.30	0.007	0.012
D	1.90	2.10	0.075	0.083
D2	1.00	1.60	0.039	0.063
E	1.90	2.10	0.075	0.083
E2	0.60	1.00	0.024	0.039
e	0.50 BSC		0.020 BSC	
L	0.30	0.45	0.012	0.018

Note : 1. Follow from JEDEC MO-229 WCCD-3.

Package Information

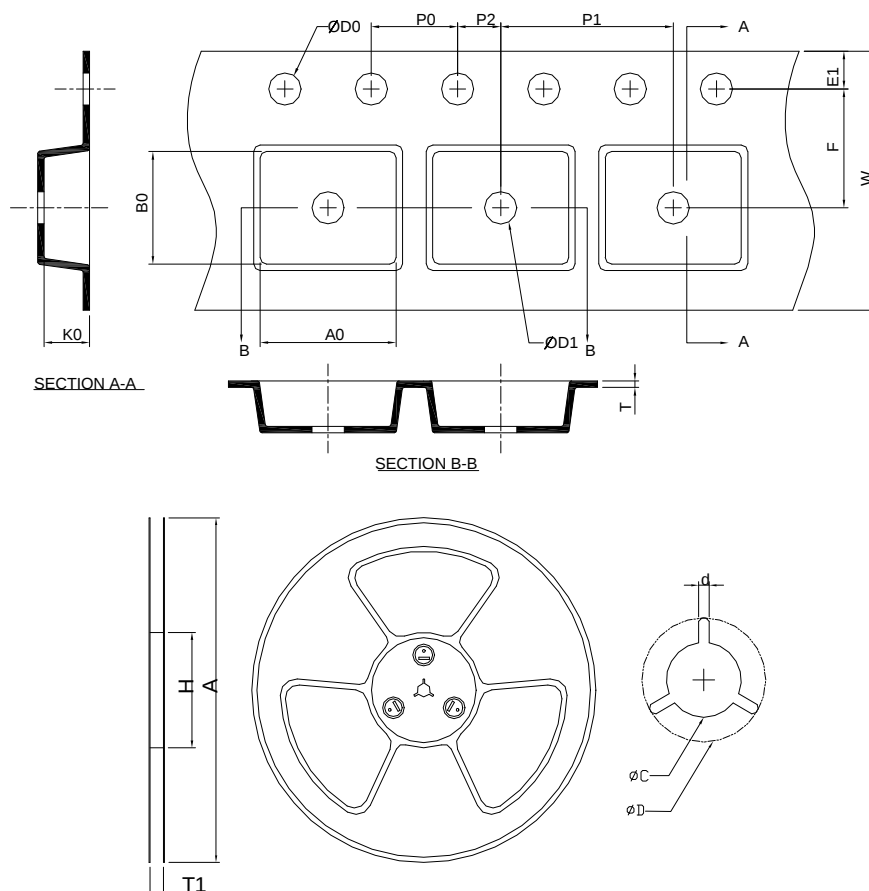
TSOT-23-6A



SYMBOL	TSOT-23-6A			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.00	0.028	0.039
A1	0.01	0.10	0.000	0.004
A2	0.70	0.90	0.028	0.035
b	0.30	0.50	0.012	0.020
c	0.08	0.20	0.003	0.008
D	2.70	3.10	0.106	0.122
E	2.60	3.00	0.102	0.118
E1	1.40	1.80	0.055	0.071
e	0.95 BSC		0.037 BSC	
e1	1.90 BSC		0.075 BSC	
L	0.30	0.60	0.012	0.024
θ	0°	8°	0°	8°

Note : Dimension D and E1 do not include mold flash, protrusions or gate burrs. Mold flash, protrusion or gate burrs shall not exceed 10 mil per side.

Carrier Tape & Reel Dimensions



Application	A	H	T1	C	d	D	W	E1	F
TDFN2x2-8	178.0 ±0.00	50 MIN.	8.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	8.0 ±0.20	1.75 ±0.10	3.50 ±0.05
	P0	P1	P2	D0	D1	T	A0	B0	K0
	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.5+0.10 -0.00	1.5 MIN.	0.6+0.00 -0.4	3.35 MIN	3.35 MIN	1.30 ±0.20
Application	A	H	T1	C	d	D	W	E1	F
TSOT-23-6A	178.0 ±0.00	50 MIN.	8.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	8.0 ±0.30	1.75 ±0.10	3.5 ±0.05
	P0	P1	P2	D0	D1	T	A0	B0	K0
	4.0 ±0.10	4.0 ±0.10	2.0 ±0.05	1.5+0.10 -0.00	1.0 MIN.	0.6+0.00 -0.40	3.20 ±0.20	3.10 ±0.20	1.50 ±0.20

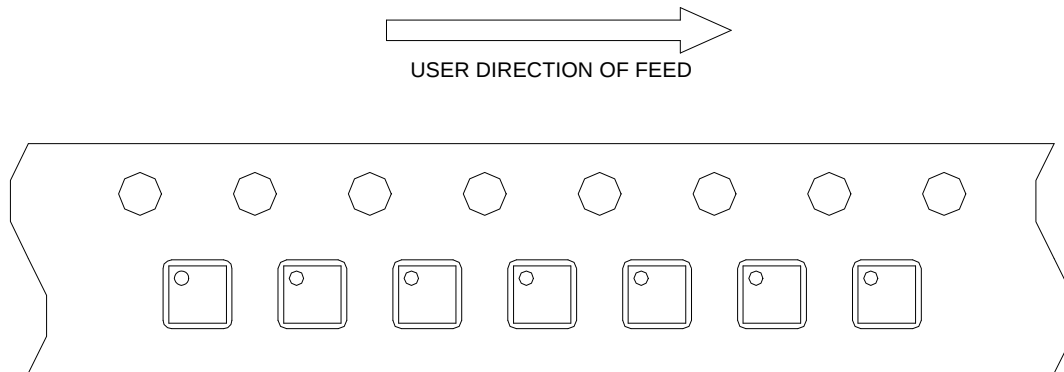
(mm)

Devices Per Unit

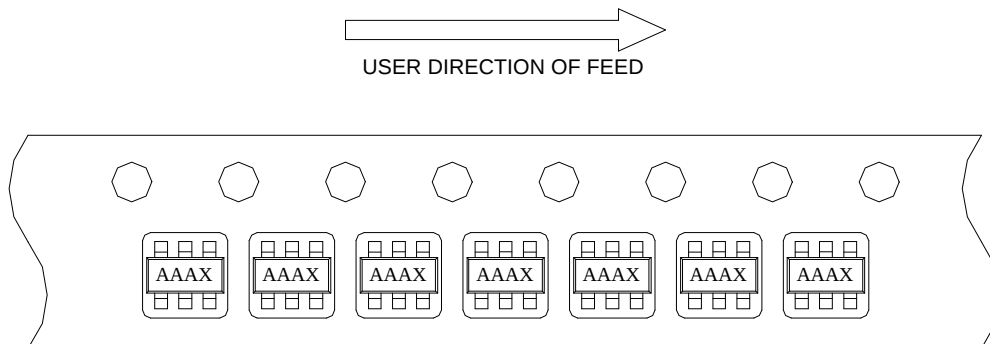
Package Type	Unit	Quantity
TDFN2x2-8	Tape & Reel	3000
TSOT-23-6A	Tape & Reel	3000

Taping Direction Information

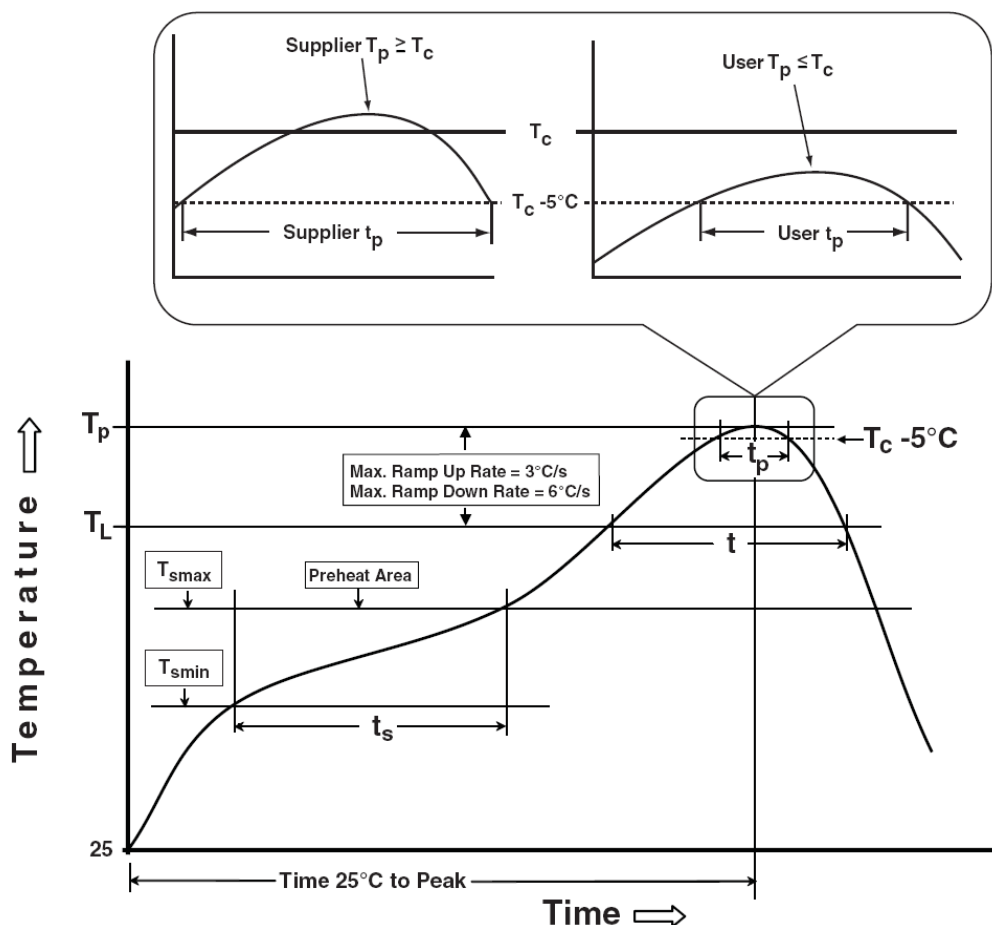
TDFN2x2-8



TSOT-23-6A



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak		
Temperature min (T_{smin})	100 °C	150 °C
Temperature max (T_{smax})	150 °C	200 °C
Time (T_{smin} to T_{smax}) (t_s)	60-120 seconds	60-120 seconds
Average ramp-up rate (T_{smax} to T_p)	3 °C/second max.	3°C/second max.
Liquidous temperature (T_L)	183 °C	217 °C
Time at liquidous (t_L)	60-150 seconds	60-150 seconds
Peak package body Temperature (T_p)*	See Classification Temp in table 1	See Classification Temp in table 2
Time (t_p)** within 5°C of the specified classification temperature (T_c)	20** seconds	30** seconds
Average ramp-down rate (T_p to T_{smax})	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
* Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum.		
** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.		

Classification Reflow Profiles (Cont.)

Table 1. SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm ³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (Tc)

Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HOLT	JESD-22, A108	1000 Hrs, Bias @ 125°C
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
TCT	JESD-22, A104	500 Cycles, -65°C~150°C
HBM	MIL-STD-883-3015.7	VHBM 2KV
MM	JESD-22, A115	VMM 200V
Latch-Up	JESD 78	10ms, 1 _{tr} 100mA

Customer Service

Anpec Electronics Corp.

Head Office :

No.6, Dusing 1st Road, SBIP,
Hsin-Chu, Taiwan, R.O.C.
Tel : 886-3-5642000
Fax : 886-3-5642050

Taipei Branch :

2F, No. 11, Lane 218, Sec 2 Jhongsing Rd.,
Sindian City, Taipei County 23146, Taiwan
Tel : 886-2-2910-3838
Fax : 886-2-2917-3838